New Jersey Semi-Conductor Products, Inc.

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MJ10012 MJH10012

10 AMPERE

POWER TRANSISTORS

NPN Silicon Power Darlington Transistor

The MJ10012 and MJH10012 are high–voltage, high–current Darlington transistors designed for automotive ignition, switching regulator and motor control applications.

- Collector-Emitter Sustaining Voltage —
- VCEO(sus) = 400 Vdc (Min)
- 175 Watts Capability at 50 Volts
 Automative Expectional Texts
- Automotive Functional Tests



DARLINGTON NPN SILICON 400 VOLTS 175 AND 118 WATTS
(TO–3) MJ10012
TO-218 TYPE MJH10012

MAXIMUM RATINGS

Rating	Symbol	MJ10012	MJH10012	Unit
Collector-Emitter Voltage	VCEO	4	Vdc	
Collector–Emitter Voltage (R _{BE} = 27 Ω)	VCER	5	Vdc	
Collector-Base Voltage	VCBO	6	Vdc	
Emitter-Base Voltage	VEBO	8	Vdc	
Collector Current — Continuous — Peak (1)	lc	10 15		Adc
Base Current	ΙB	2.0		Adc
Total Power Dissipation @ T _C = 25°C @ T _C = 100°C Derate above 25°C	PD	175 100 1.0	118 47.5 1.05	Watts Watts W/°C
Operating and Storage Junction Temperature Range	т _Ј , т _{stg}	-65 to +200	-55 to +150	°C

THERMAL CHARACTERISTICS

Characteristic	Symbol	Мах		Unit	
Thermal Resistance, Junction to Case	R _{θJC}	1.0	0.95	°C/W	
Maximum Lead Temperature for Soldering Purposes: 1/8″ from Case for 5 Seconds	т	275	275	°C	

(1) Pulse Test: Pulse Width = 5.0 ms, Duty Cycle \leq 10%.



NJ Semi-Conductors reserves the right to change test conditions, parameter limits and package dimensions without notice. Information furnished by NJ Semi-Conductors is believed to be both accurate and reliable at the time of going to press. However, NJ Semi-Conductors assumes no responsibility for any errors or omissions discovered in its use. NJ Semi-Conductors encourages customers to verify that datasheets are current before placing orders.

Quality Semi-Conductors

MJ10012 MJH10012

ELECTRICAL CHARACTERISTICS (T_C = 25°C unless otherwise noted)

	Characteristic	Symbol	Min	Тур	Max	Unit
OFF CHARACTERISTIC	S (1)			•		
	ining Voltage (Figure 1) 0, V _{clamp} = Rated V _{CEO})	VCEO(sus)	400	-	_	Vdc
	iining Voltage (Figure 1) <u>-</u> = 27 Ohms, V _{Clamp} ≐ Rated V _{CER})	VCER(sus)	425	—	—	Vdc
Collector Cutoff Current (Rated V _{CER} , R _{BE} = 27 Ohms)		ICER	_	-	1.0	mAdc
Collector Cutoff Current	t (Rated V _{CBO} , $I_E = 0$)	Ісво	—	—	1.0	mAdc
Emitter Cutoff Current ($V_{EB} = 6.0 \text{ Vdc}, I_{C} = 0)$	^I EBO	_	—	40	mAdc
ON CHARACTERISTICS	; (1)					
DC Current Gain (I _C = 3.0 Adc, V _{CE} = (I _C = 6.0 Adc, V _{CE} = (I _C = 10 Adc, V _{CE} =	6.0 Vdc)	hfe	300 100 20	550 350 150	 2000 	
$\label{eq:constraint} \begin{array}{l} \mbox{Collector-Emitter Satur} \\ \mbox{(I}_{C}=3.0 \mbox{ Adc}, \mbox{ I}_{B}=0. \\ \mbox{(I}_{C}=6.0 \mbox{ Adc}, \mbox{ I}_{B}=0. \\ \mbox{(I}_{C}=10 \mbox{ Adc}, \mbox{ I}_{B}=2.0 \end{array}$	6 Adc) 6 Adc)	VCE(sat)		-	1 5 2.0 2.5	Vdc
Base Emitter Saturation (I _C = 6.0 Adc, I _B = 0. (I _C = 10 Adc, I _B = 2.0	6 Adc)	VBE(sat)	_	_	2.5 3.0	Vdc
Base Emitter On Voltage (I _C = 10 Adc, V _{CE} = 6.0 Vdc)		V _{BE(on)}	_	—	2.8	Vdc
Diode Forward Voltage (IF = 10 Adc)		V _f	_	2.0	3.5	Vdc
DYNAMIC CHARACTER	ISTICS	·		•		
Output Capacitance (V _{CB} = 10 Vdc, I _E = 0, f _{test} = 100 kHz)		C _{ob}	—	165	350	pF
SWITCHING CHARACTE	ERISTICS					
Storage Time	(V _{CC} = 12 Vdc, I _C = 6.0 Adc,	ts	_	75	15	μs
Fall Time			_	5.2	15	μs
FUNCTIONAL TESTS						
Second Breakdown Collector Current with Base–Forward Biased See Figure 10		0	-			

 Base-Forward Biased
 IC2L/2
 - 180
 mJ

(1) Pulse Test: Pulse Width = 300 µs, Duty Cycle = 2%.





* Adjust t₁ such that I_C reaches 200 mA at V_{CE} = V_{clamp}

Figure 1. Sustaining Voltage Test Circuit

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Figure 2. Switching Times Test Circuit